

# NI DAQPad™ -6015/6016 Family Specifications

This document lists the I/O terminal summary and specifications for the NI DAQPad-6015/6016 family of devices. This family includes the following devices:

- NI DAQPad-6015
- NI DAQPad-6015 mass termination
- NI DAQPad-6015 BNC
- NI DAQPad-6016

## I/O Terminal Summary



**Note** With NI-DAQmx, National Instruments revised its terminal names so they are easier to understand and more consistent among NI hardware and software products. The revised terminal names used in this document are usually similar to the names they replace. For a complete list of Traditional NI-DAQ (Legacy) terminal names and their NI-DAQmx equivalents, refer to *Terminal Name Equivalents of the E Series Help*.

**Table 1.** I/O Terminals

Terminal Name	Terminal Type and Direction	Impedance Input/ Output	Protection (V) On/Off	Source (mA at V)	Sink (mA at V)	Rise Time (ns)	Bias
AI <0..15>	AI	100 GΩ in parallel with 100 pF	25/15	—	—	—	±200 pA
AI SENSE	AI	100 GΩ in parallel with 100 pF	25/15	—	—	—	±200 pA
AI GND	—	—	—	—	—	—	—
AO 0	AO	0.1 Ω	Short-circuit to ground	5 at 10	5 at -10	—	—
AO 1	AO	0.1 Ω	Short-circuit to ground	5 at 10	5 at -10	—	—
AO GND	—	—	—	—	—	—	—
D GND	—	—	—	—	—	—	—

**Table 1.** I/O Terminals (Continued)

Terminal Name	Terminal Type and Direction	Impedance Input/ Output	Protection (V) On/Off	Source (mA at V)	Sink (mA at V)	Rise Time (ns)	Bias
+5 V	—	0.1 $\Omega$	Short-circuit to ground	1 A fuse	—	—	—
P0.<0..7>	DIO	—	$V_{CC} + 0.5$	13 at ( $V_{CC} - 0.4$ )	24 at 0.4	1.1	50 k $\Omega$ pu
P1.<0..7> <sup>†</sup>	DIO	—	$V_{CC} + 0.5$	2.5 at 3.0 min	2.5 at 0.4	5	100 k $\Omega$ pu
P2.<0..7> <sup>†</sup>	DIO	—	$V_{CC} + 0.5$	2.5 at 3.0 min	2.5 at 0.4	5	100 k $\Omega$ pu
P3.<0..7> <sup>†</sup>	DIO	—	$V_{CC} + 0.5$	2.5 at 3.0 min	2.5 at 0.4	5	100 k $\Omega$ pu
AI HOLD COMP	DO	—	—	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
EXT STROBE*	DO	—	—	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 0/ (AI START TRIG)	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 1/ (AI REF TRIG)	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 2/ (AI CONV CLK)*	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 3/ CTR 1 SOURCE	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 4/CTR 1 GATE	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
CTR 1 OUT	DO	—	—	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 5/ (AO SAMP CLK)*	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 6/ (AO START TRIG)	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 7/ (AI SAMP CLK)	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 8/ CTR 0 SOURCE	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu
PFI 9/CTR 0 GATE	DIO	—	$V_{CC} + 0.5$	3.5 at ( $V_{CC} - 0.4$ )	5 at 0.4	1.5	50 k $\Omega$ pu

**Table 1.** I/O Terminals (Continued)

Terminal Name	Terminal Type and Direction	Impedance Input/Output	Protection (V) On/Off	Source (mA at V)	Sink (mA at V)	Rise Time (ns)	Bias
CTR 0 OUT	DO	—	—	3.5 at (V <sub>CC</sub> - 0.4)	5 at 0.4	1.5	50 kΩ pu
FREQ OUT	DO	—	—	3.5 at (V <sub>CC</sub> - 0.4)	5 at 0.4	1.5	50 kΩ pu
<p>* Indicates active low.                      † NI 6016 only.                      AI = Analog Input    DIO = Digital Input/Output    pu = pull-up                      AO = Analog Output    DO = Digital Output  <b>Note:</b> The tolerance on the 50 kΩ pull-up resistors is large. Actual value might range between 17 kΩ and 100 kΩ.</p>							

## Specifications

The following specifications are typical at 25 °C unless otherwise noted.

### Analog Input

#### Input Characteristics

Number of channels ..... 16 single-ended or  
 8 differential  
 (software-selectable  
 per channel)

Type of ADC ..... Successive  
 approximation

Resolution ..... 16 bits, 1 in 65,536

Max sampling rate ..... 200 kS/s guaranteed

Input signal ranges (bipolar only) ... ±10 V, ±5 V, ±500 mV,  
 ±50 mV

Input coupling ..... DC

Maximum working voltage..... Each input should remain  
 within ±11 V of ground

#### Overtoltage protection

Signal Name	Powered Off	Powered On
AI <0..15>	±15 V	±25 V
AI SENSE	±15 V	±25 V

FIFO buffer size ..... 4,096 samples

Data transfers ..... Interrupts,  
 programmed I/O

Configuration memory size ..... 512 words

## Accuracy Information

Nominal Range at Full Scale (V)	Absolute Accuracy						Relative Accuracy Resolution ( $\mu\text{V}$ )		
	% of Reading		Offset ( $\mu\text{V}$ )	Noise + Quantization ( $\mu\text{V}$ )		Absolute Accuracy at Full Scale (mV)	Temp Drift ( $^\circ\text{C}$ )	Single Pt.	Averaged
	24 Hours	1 Year		Single Pt.	Averaged				
$\pm 10$	0.0658	0.0700	1897.5	933.0	82.40	8.984	0.0010	1084.9	108.5
$\pm 5$	0.0158	0.0200	959.8	466.5	41.20	2.003	0.0005	542.4	54.2
$\pm 0.5$	0.0658	0.0700	115.8	56.2	5.035	0.471	0.0010	66.3	6.6
$\pm 0.05$	0.0658	0.0700	31.4	31.40	3.067	0.069	0.0010	40.4	4.0

**Note:** Accuracies are valid for measurements following an internal E Series calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within  $\pm 1^\circ\text{C}$  of internal calibration temperature and  $\pm 10^\circ\text{C}$  of external or factory-calibration temperature. NI recommends a one-year calibration interval. The Absolute Accuracy at Full Scale calculations were performed for a maximum range input voltage (for example, 10 V for the  $\pm 10$  V range) after one year, assuming 100 points of averaged data. Go to [ni.com/info](http://ni.com/info) and enter info code `rdspec` for example calculations.

### Transfer Characteristics

INL .....  $\pm 1.5$  LSB typ,  
 $\pm 3.0$  LSB max

No missing codes ..... 16 bits, guaranteed

Offset error

  Pregain error after calibration .....  $\pm 2.0$   $\mu\text{V}$  max

  Pregain error before calibration .....  $\pm 28.8$  mV max

  Postgain error after calibration ...  $\pm 305$   $\mu\text{V}$  max

  Postgain error before calibration .....  $\pm 40.2$  mV max

Gain error (relative to calibration reference)

  After calibration (gain = 1) .....  $\pm 74$  ppm of reading max

  Before calibration .....  $\pm 18,900$  ppm of reading max

  Gain  $\neq 1$  with gain error adjusted to 0 at gain = 1 .....  $\pm 300$  ppm of reading max

### Amplifier Characteristics

Input impedance

  Normal powered on ..... 100 G $\Omega$  in parallel with 100 pF

  Powered off ..... 820  $\Omega$

  Overload ..... 820  $\Omega$

### BNC version

Powered on

  CH+ (AI <0..7>) ..... 100 G $\Omega$  in parallel with 100 pF

  CH- (AI <8..15>)

    With built-in bias resistor disengaged ..... 100 G $\Omega$  in parallel with 100 pF

    With built-in bias resistor engaged (default) ..... 5 K $\Omega$  in parallel with 0.1  $\mu\text{F}$

  Powered off ..... 820  $\Omega$  min

  Overload ..... 820  $\Omega$  min

Input bias current .....  $\pm 200$  pA

Input offset current .....  $\pm 100$  pA

CMRR (DC to 60 Hz)

  Gain 0.5, 1.0 ..... 85 dB

  Gain 10, 100 ..... 96 dB

### Dynamic Characteristics

#### Bandwidth

Signal	Bandwidth
Small ( $-3$ dB)	425 kHz
Large (1% THD)	450 kHz

### Settling time for full-scale step

Gain 10, 100 .....  $\pm 2$  LSB, 5  $\mu$ s typ  
Gain 1 .....  $\pm 2$  LSB, 5  $\mu$ s max  
Gain 0.5 .....  $\pm 4$  LSB, 5  $\mu$ s typ

### System noise ( $LSB_{rms}$ , including quantization)

Input Range	$LSB_{rms}$
$\pm 10$ V, $\pm 5$ V	0.9
$\pm 500$ mV	1.1
$\pm 50$ mV	6.7

Crosstalk ..... DC to 100 kHz  
Adjacent channels .....  $-75$  dB  
Other channels .....  $\leq -90$  dB

### Stability

Recommended warm-up time ..... 15 min  
Offset temperature coefficient  
Pregain .....  $\pm 20$   $\mu$ V/ $^{\circ}$ C  
Postgain .....  $\pm 175$   $\mu$ V/ $^{\circ}$ C  
Gain temperature coefficient .....  $\pm 32$  ppm/ $^{\circ}$ C

## Analog Output

### Output Characteristics

Number of channels ..... 2 voltage  
Resolution ..... 16 bits, 1 in 65,536  
Max update rate  
Software timed ..... 300 S/s,  
system dependent  
Hardware timed ..... 50 S/s, system dependent  
Type of DAC ..... Double-buffered,  
multiplying  
FIFO buffer size ..... None  
Data transfers ..... Interrupts,  
programmed I/O

## Accuracy Information

Nominal Range at Full Scale (V)		Absolute Accuracy				
Positive Full Scale	Negative Full Scale	% of Reading		Offset ( $\mu\text{V}$ )	Temp Drift ( $\%/^{\circ}\text{C}$ )	Absolute Accuracy at Full Scale ( $\mu\text{V}$ )
		24 Hours	1 Year			
10	-10	0.0252	0.0337	2,461	0.0005	5,827

**Note:** Accuracies are valid for measurements following an internal E Series calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within  $\pm 1^{\circ}\text{C}$  of internal calibration temperature and  $\pm 10^{\circ}\text{C}$  of external or factory-calibration temperature. NI recommends a one-year calibration interval. The Absolute Accuracy at Full Scale calculations were performed for a maximum range input voltage (for example, 10 V for the  $\pm 10\text{ V}$  range) after one year, assuming 100 points of averaged data. Go to [ni.com/info](http://ni.com/info) and enter info code `rdspec` for example calculations.

### Transfer Characteristics

Relative accuracy (INL) .....	$\pm 3$ LSB, typ
DNL .....	$\pm 2$ LSB, typ
Monotonicity .....	15 bits
Offset error	
After calibration .....	$\pm 372\ \mu\text{V}$ max
Before calibration .....	$\pm 250\ \text{mV}$ max
Gain error (relative to internal reference)	
After calibration .....	$\pm 75$ ppm
Before calibration .....	$\pm 22,700$ ppm

### Voltage Output

Range .....	$\pm 10\ \text{V}$
Output coupling .....	DC
Output impedance .....	$0.1\ \Omega$ max
Current drive .....	$\pm 5\ \text{mA}$ max
Protection .....	Short-circuit to ground
Power-on state (steady state) .....	$\pm 250\ \text{mV}$
Initial power-up glitch	
Magnitude .....	$\pm 6.0\ \text{V}$
Duration .....	4 ms
Power reset glitch	
Magnitude .....	$\pm 3.0\ \text{V}$
Duration .....	3 ms

### Dynamic Characteristics

Settling time for full-scale step .....	8 $\mu\text{s}$ to $\pm 1$ LSB accuracy
Slew rate .....	4 $\text{V}/\mu\text{s}$

Noise ..... 360  $\mu\text{V}_{\text{rms}}$   
DC to 400 kHz

### Midscale transition glitch

Magnitude .....	$\pm 100\ \text{mV}$
Duration .....	4.0 $\mu\text{s}$

### Stability

Offset temperature coefficient .....	$\pm 128\ \mu\text{V}/^{\circ}\text{C}$
Gain temperature coefficient .....	$\pm 26.8\ \text{ppm}/^{\circ}\text{C}$

### Digital I/O

Number of channels	
NI DAQPad-6015 .....	8 input/output
NI DAQPad-6016 .....	32 input/output
Compatibility .....	5 V TTL/CMOS

### PO.<0..7>

Digital logic levels

Level	Min	Max
Input low voltage	0 V	0.8 V
Input high voltage	2.0 V	5.0 V
Input low current ( $V_{\text{in}} = 0\ \text{V}$ )	—	-320 $\mu\text{A}$
Input high current ( $V_{\text{in}} = 5\ \text{V}$ )	—	3.33 mA
Output low voltage ( $I_{\text{OL}} = 24\ \text{mA}$ )	—	0.4 V
Output high voltage ( $I_{\text{OH}} = -13\ \text{mA}$ )	4.35 V	—

Power-on state..... Input (high-impedance),  
1.5 k $\Omega$  pull down to  
D GND

Data transfers ..... Programmed I/O

Max transfer rate ..... 250 S/s,  
system dependent

**P1.<0..7>, P2.<0..7>, P3.<0..7>**  
**(NI DAQPad-6016 Only)**

Digital logic levels

Level	Min	Max
Input low voltage	0 V	0.8 V
Input high voltage	2.2 V	5.0 V
Input low current ( $V_{in} = 0$ V, 100 k $\Omega$ pu)	—	-75 $\mu$ A
Input high current ( $V_{in} = 5$ V, 100 k $\Omega$ pu)	—	10 $\mu$ A
Output low voltage ( $I_{OL} = 2.5$ mA)	—	0.4 V
Output high voltage ( $I_{OH} = -2.5$ mA)	3.0 V	—

Handshaking ..... 2-wire

Power-on state

P1.<0..7> ..... Input (high-impedance),  
100 k $\Omega$  pull-up to  
+5 VDC

P2.<0..7> ..... Input (high-impedance),  
100 k $\Omega$  pull-up to  
+5 VDC

P3.<0..7> ..... Input (high-impedance),  
100 k $\Omega$  pull-up to  
+5 VDC

Data transfers ..... Interrupts,  
programmed I/O

Max transfer rate ..... 250 S/s,  
system dependent

**Timing I/O**

Number of channels

Up/down counter/timers ..... 2

Frequency scaler ..... 1

Resolution

Up/down counter/timers ..... 24 bits

Frequency scaler ..... 4 bits

Compatibility ..... 5 V TTL/CMOS

Digital logic levels

Level	Min	Max
Input low voltage	0.0 V	0.8 V
Input high voltage	2.0 V	5.0 V
Output low voltage ( $I_{out} = 5$ mA)	—	0.4 V
Output high voltage ( $I_{out} = -3.5$ mA)	4.35 V	—

Base clocks available

Up/down counter/timers ..... 20 MHz, 100 kHz

Frequency scaler ..... 10 MHz, 100 kHz

Base clock accuracy .....  $\pm 0.01\%$

Max external source frequency

Up/down counter/timers ..... 20 MHz

External source selections ..... PFI <0..9>

External gate selections ..... PFI <0..9>

Min source pulse duration ..... 10 ns in edge-detect mode

Min gate pulse duration ..... 10 ns in edge-detect mode

Data transfers

Up/down counter/timers ..... Interrupts,  
programmed I/O

Frequency scaler ..... Programmed I/O

## Digital Trigger

Purpose	
Analog input .....	Start, reference, and pause trigger, sample clock
Analog output .....	Start and pause trigger, sample clock
Counter/timers .....	Source, gate
Source .....	PFI <0..9>
Compatibility .....	5 V TTL
Response .....	Rising or falling edge
Pulse width .....	10 ns min
External input for digital trigger	
Protection .....	-0.5 V to $V_{CC} + 0.5 V$

## Calibration

Recommended warm-up time .....	15 minutes
Calibration interval .....	1 year
External calibration reference .....	>6 V and <10 V
Onboard calibration reference	
Level .....	5.000 V ( $\pm 3.5$ mV), over full operating temperature, actual value stored in EEPROM
Temperature coefficient .....	$\pm 5.0$ ppm/ $^{\circ}C$ max
Long-term stability .....	$\pm 15.0$ ppm/ $\sqrt{1,000 h}$

## Bus Interface

Type .....	USB, full-speed
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## Power Requirement

9-25 V .....	12 W
Power available at I/O connector ....	+4.65 to +5.25 VDC at 1 A



**Note** Power supply voltages are absolute minimum and maximum values.

## Physical

Dimensions (not including connectors)	
NI DAQPad-6015/6016 .....	17.6 cm $\times$ 14.85 cm $\times$ 3.08 cm (8 in. $\times$ 6.75 in. $\times$ 1.4 in.)
NI DAQPad-6015 mass termination, DAQPad-6015 BNC .....	30.7 cm $\times$ 25.4 cm $\times$ 4.3 cm (12.1 in. $\times$ 10 in. $\times$ 1.7 in.)

## Weight

NI DAQPad-6015/6016 .....	907 g (2 lb)
NI DAQPad-6015 mass termination .....	1417 g (3.125 lb)
NI DAQPad BNC .....	1735 g (3.825 lb)

## I/O connector

NI DAQPad-6015/6016 .....	Screw terminals
NI DAQPad-6015 mass termination .....	SCSI-II
NI DAQPad BNC .....	BNCs and removable screw terminals

## Maximum Working Voltage

Maximum working voltage refers to the signal voltage plus the common-mode voltage.

Channel-to-earth .....	11 V, Installation Category I
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## Environmental

Operating temperature .....	0 to 50 $^{\circ}C$
Storage temperature .....	-55 to 150 $^{\circ}C$
Humidity .....	5 to 90% RH, noncondensing
Maximum altitude .....	2,000 meters
Pollution Degree (indoor use only) .....	2



**Note** Clean the device with a soft, non-metallic brush. Make sure that the device is completely dry and free from contaminants before returning it to service.

## Safety

These products are designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 60950-1, EN 60950-1
- UL 60950-1
- CAN/CSA-C22.2 No. 60950-1



**Note** For UL and other safety certifications, refer to the product label, or visit [ni.com/certification](http://ni.com/certification), search by model number or product line, and click the appropriate link in the Certification column.



## Electromagnetic Compatibility

Emissions .....	EN 55011 Class A at 10 m FCC Part 15A above 1 GHz
Immunity .....	EN 61326:1997 A2:2001, Table 1

CE, C-Tick, and FCC Part 15 (Class A) Compliant



**Note** For EMC compliance, operate this device with shielded cabling.

## CE Compliance

These products meet the essential requirements of applicable European Directives, as amended for CE marking, as follows:

Low-Voltage Directive (safety) ..... 73/23/EEC

Electromagnetic Compatibility  
Directive (EMC) ..... 89/336/EEC



**Note** Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for these products, visit [ni.com/certification](http://ni.com/certification), search by model number or product line, and click the appropriate link in the Certification column.

Digital and Timing				Analog			
P0.0	33	49	CTR 0 OUT	AI 0	1	17	AI 4
P0.1	34	50	PFI 8/CTR 0 SOURCE	AI 8	2	18	AI 12
D GND	35	51	D GND	AI GND	3	19	AI GND
P0.2	36	52	PFI 9/CTR 0 GATE	AI 1	4	20	AI 5
P0.3	37	53	PFI 5/AO SAMP CLK	AI 9	5	21	AI 13
P0.4	38	54	PFI 6/AO START TRIG	AI GND	6	22	AI GND
D GND	39	55	D GND	AI 2	7	23	AI 6
P0.5	40	56	PFI 7/AI SAMP CLK	AI 10	8	24	AI 14
P0.6	41	57	CTR 1 OUT	AI GND	9	25	AI GND
P0.7	42	58	PFI 3/CTR 1 SOURCE	AI 3	10	26	AI 7
D GND	43	59	D GND	AI 11	11	27	AI 15
AI HOLD COMP	44	60	PFI 4/CTR 1 GATE	AI GND	12	28	AI GND
EXT STROBE	45	61	PFI 1/AI REF TRIG	AI SENSE	13	29	AI GND
PFI 2/AI CONV CLK	46	62	PFI 0/AI START TRIG	AI GND	14	30	AI GND
+5 V	47	63	D GND	AO 0	15	31	AO 1
D GND	48	64	FREQ OUT	AO GND	16	32	AO GND

**Figure 1.** NI DAQPad-6015 Pinout

PFI 9	2	1	P0.7
PFI 8	4	3	P0.6
PFI 7	6	5	P0.5
PFI 6	8	7	P0.4
PFI 5	10	9	P0.3
PFI 4	12	11	P0.2
PFI 3	14	13	P0.1
PFI 2	16	15	P0.0
PFI 1	18	17	CTR 1 OUT
D GND	20	19	D GND
USER 2	22	21	USER 1
FREQ OUT	24	23	AI HOLD COMP
+5 V	26	25	EXT STROBE
+5 V	28	27	AI SENSE
D GND	30	29	AI GND

**Figure 2.** NI DAQPad-6015 BNC Pinout

AI 8	34	68	AI 0
AI 1	33	67	AI GND
AI GND	32	66	AI 9
AI 10	31	65	AI 2
AI 3	30	64	AI GND
AI GND	29	63	AI 11
AI 4	28	62	AI SENSE
AI GND	27	61	AI 12
AI 13	26	60	AI 5
AI 6	25	59	AI GND
AI GND	24	58	AI 14
AI 15	23	57	AI 7
AO 0	22	56	AI GND
AO 1	21	55	AO GND
NC	20	54	AO GND
P0.4	19	53	D GND
D GND	18	52	P0.0
P0.1	17	51	P0.5
P0.6	16	50	D GND
D GND	15	49	P0.2
+5 V	14	48	P0.7
D GND	13	47	P0.3
D GND	12	46	AI HOLD COMP
PFI 0/AI START TRIG	11	45	EXT STROBE
PFI 1/AI REF TRIG	10	44	D GND
D GND	9	43	PFI 2/AI CONV CLK
+5 V	8	42	PFI 3/CTR 1 SRC
D GND	7	41	PFI 4/CTR 1 GATE
PFI 5/AO SAMP CLK	6	40	CTR 1 OUT
PFI 6/AO START TRIG	5	39	D GND
D GND	4	38	PFI 7/AI SAMP CLK
PFI 9/CTR 0 GATE	3	37	PFI 8/CTR 0 SRC
CTR 0 OUT	2	36	D GND
FREQ OUT	1	35	D GND

NC = No Connect

**Figure 3.** NI DAQPad-6015 Mass Termination Pinout

Extended Digital			Digital and Timing			Analog					
P3.7	96	80	P3.3	P0.0	33	49	CTR 0 OUT	AI 0	1	17	AI 4
D GND	95	79	D GND	P0.1	34	50	PFI 8/CTR 0 SOURCE	AI 8	2	18	AI 12
P3.6	94	78	P3.2	D GND	35	51	D GND	AI GND	3	19	AI GND
P3.5	93	77	P3.1	P0.2	36	52	PFI 9/CTR 0 GATE	AI 1	4	20	AI 5
P3.4	92	76	P3.0	P0.3	37	53	PFI 5/AO SAMP CLK	AI 9	5	21	AI 13
D GND	91	75	D GND	P0.4	38	54	PFI 6/AO START TRIG	AI GND	6	22	AI GND
P2.7	90	74	P2.3	D GND	39	55	D GND	AI 2	7	23	AI 6
P2.6	89	73	P2.2	P0.5	40	56	PFI 7/AI SAMP CLK	AI 10	8	24	AI 14
P2.5	88	72	P2.1	P0.6	41	57	CTR 1 OUT	AI GND	9	25	AI GND
D GND	87	71	D GND	P0.7	42	58	PFI 3/CTR 1 SOURCE	AI 3	10	26	AI 7
P2.4	86	70	P2.0	D GND	43	59	D GND	AI 11	11	27	AI 15
P1.7	85	69	P1.3	AI HOLD COMP	44	60	PFI 4/CTR 1 GATE	AI GND	12	28	AI GND
P1.6	84	68	P1.2	EXT STROBE	45	61	PFI 1/AI REF TRIG	AI SENSE	13	29	AI GND
D GND	83	67	D GND	PFI 2/AI CONV CLK	46	62	PFI 0/AI START TRIG	AI GND	14	30	AI GND
P1.5	82	66	P1.1	+5 V	47	63	D GND	AO 0	15	31	AO 1
P1.4	81	65	P1.0	D GND	48	64	FREQ OUT	AO GND	16	32	AO GND

**Figure 4.** NI DAQPad-6016 Pinout

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